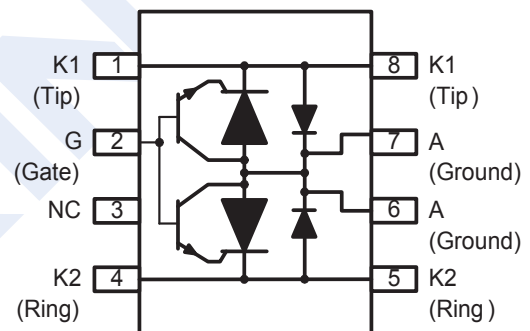
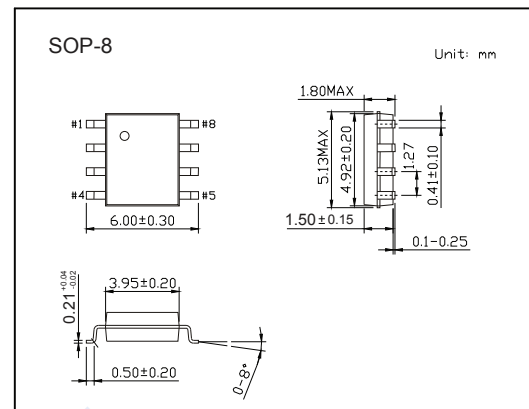


Thyristor Programmable Overvoltage Protector

1KE61089DY

■ Features

- Dual programmable transient suppressor.
- Wide negative firing voltage range:
 $V_{GKRM} = -167V$ max.
- Low dynamic switching voltage:
 V_{FRM} and $V_{GK(BD)}$
- Low gate triggering current:
 $I_{GT} = 5mA$ max
- Peak pulse current:
 $I_{PP} = 30A$ for 10/1000 μs surge
- Holding current:
 $I_H = 150mA$ min.
- Complies with The Following Standards
YD/T 950-1998
ITU-T K.20
FCC part 68
GR-1089-CORE



■ Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Non-repetitive peak on-state pulse current	I_{PP}	10/1000 μs	30
		5/310 μs	40
		2/10 μs	120
Non repetitive surge peak on-state current (sinusoidal) 60Hz	I_{TSM}	0.5s	6.5
		1s	4.5
		5s	2.3
		30s	1.3
		900s	0.72
Maximum voltage LINE/GROUND	V_{DRM}	-170	V
Maximum voltage GATE/LINE	V_{GKRM}	-167	V
Junction to ambient	$R_{TH(j-a)}$	120	$^{\circ}C/W$
Operating free-air temperature range	T_A	-40 to +85	$^{\circ}C$
Lead soldering temperature	T_L	260	
Operating temperature	T_J	-40 to +150	
Storage temperature range	T_{STG}	-40 to +150	

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■ Electrical Characteristics ($T_{amb}=25^{\circ}\text{C}$)

Symbol	Parameter
I_D	Off-state current
I_H	Holding current
$V_{(BO)}$	Breakover voltage
V_F	Forward voltage
V_{FRM}	Peak forward recovery voltage
$V_{GK(BO)}$	Gate-cathode impulse breakover voltage
I_{GKS}	Gate reverse current
I_{GT}	Gate trigger current
V_{GT}	Gate-cathode trigger voltage
C_{KA}	Cathode-anode off-state capacitance

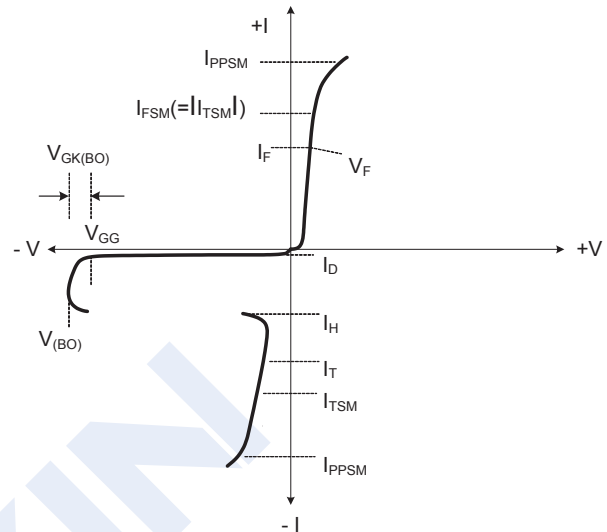


Figure 1. Voltage-Current Characteristic
Unless Otherwise Noted, All Voltages are
Referenced to the Anode

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Off-state current	I_D	$V_D=-170\text{V}, V_{GK}=0$	$T_J=25^{\circ}\text{C}$		-5	μA
			$T_J=85^{\circ}\text{C}$		-50	
Breakover voltage	V_{BO}	$2/10\mu\text{s}, I_T=-100\text{A}, R_s=50\Omega, V_{GG}=-100\text{V}, C_G=220\text{nF}$			-112	V
Holding current	I_H	$I_T=-1\text{A}, di/dt=1\text{A/ms}, V_{GG}=-100\text{V}$	-150			mA
Gate reverse current	I_{GKS}	$V_{GG}=V_{GK}=-100\text{V}, V_{KA}=0$	$T_J=25^{\circ}\text{C}$		-5	μA
			$T_J=85^{\circ}\text{C}$		-50	
Gate trigger current	I_{GT}	$I_T=3\text{A}, t_p(g)\geq 20\mu\text{s}, V_{GG}=-100\text{V}$			5	mA
Gate trigger voltage	V_{GT}	$I_T=3\text{A}, t_p(g)\geq 20\mu\text{s}, V_{GG}=-100\text{V}$			2.5	V
Gate switching charge	Q_{GS}	$1.2/50\mu\text{s}, I_T=-53\text{A}, R_s=47\Omega, V_{GG}=-100\text{V}, C_G=220\text{nF}$		0.1		μC
Cathode-anode off-state capacitance	C_{KA}	$f=1\text{MHz}, V_d=1\text{V}, I_G=0$	$V_D=-3\text{V}$		100	pF
			$V_D=-48\text{V}$		50	
Diode forward voltage	V_F	$I_F=5\text{A}, t_w=200\mu\text{s}$			3	V
Diode peak forward recovery voltage	V_{FRM}	$2/10\mu\text{s}, I_F=100\text{A}, R_s=50\Omega, V_{GG}=-100\text{V}, C_G=220\text{nF}$			10	

■ Marking

Marking	61089
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